

Group Meeting Talk

Single hole spin relaxation probed by fast single-shot latched charge sensing

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Communications Physics **2**, Article number: 17 (2019)

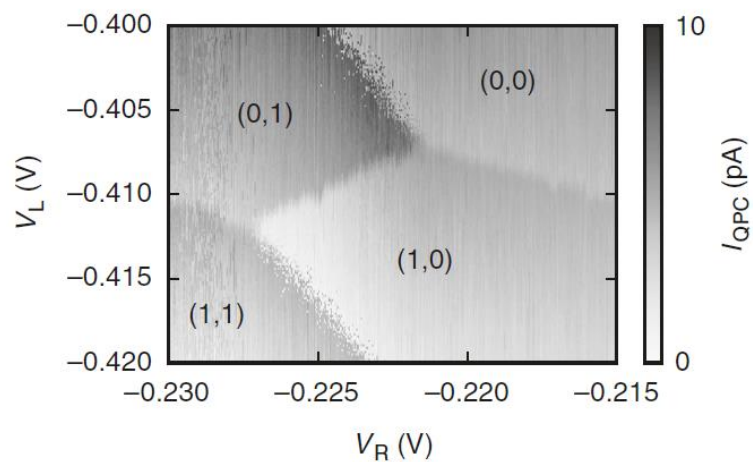
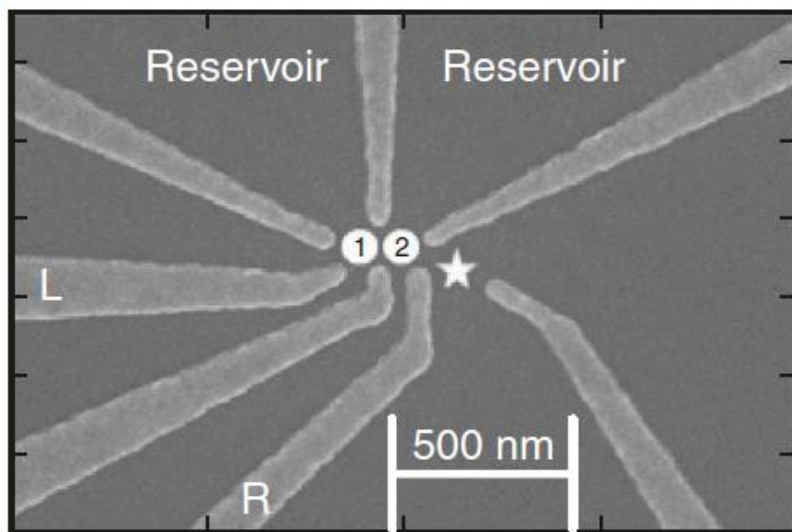
Background

- B up to several mT: flip-flop interactions with nuclear spins
 - Electrons in gated GaAs QDs: 10-100 ns near zero field (Hanson et al., 2007), $\sim 70 \mu\text{s}$ at 100 mT (Petta et al., 2005); dependence of $T_1 \propto B^{-3}$
 - Holes in GaAs: Hyperfine interaction strength is an order of magnitude weaker, translating to an improved T_1 (~ 1 ms in InGaAs sample at 250 mT (Gerardot et al., 2008))
- Higher B: Spin relaxation via phonon-mediated SOI
 - Electrons in GaAs: $T_1 \sim 1$ s at 1-2 T (Amasha et al., 2008), $T_1 \propto B^{-5}$
 - GaAs hole sample: $T_1 \sim 300$ ns at $B=0.5$ T (Wang et al., 2016)
 - Theory for holes: $T_1 \propto B^{-5}$ for Dresselhaus SOI, $T_1 \propto B^{-9}$ for Rashba SOI (Bulaev et al., 2005) & exact functional relationship depends on structural properties of QD (e.g. shape, size, thickness, strain)

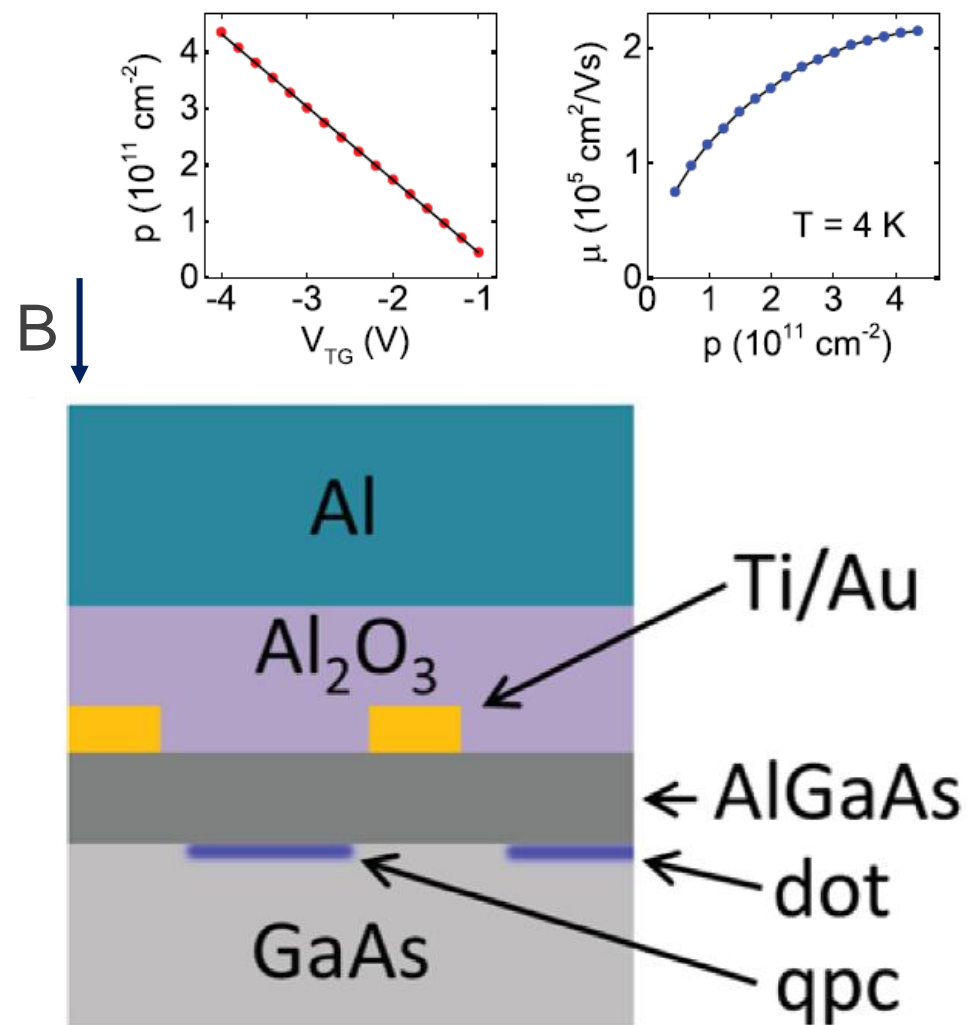
Latched charge sensing technique

- Idea: Convert short-lived spin states into long-lived metastable charge states
- Hole GaAs dot: Strong spin-flip tunneling due to SOI suppresses spin-to-charge conversion with Pauli-blockaded state
- Charge detection in the system is not sufficiently fast for spin-selective time-resolved tunneling to leads
- Paper: Fast single-shot measurements of spin states for single hole in GaAs via latched charge state

Sample layout



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L. A. Tracy et al., Appl. Phys. Lett. **104**, 123101 (2014)

Spin readout protocol

- Pulse sequence applied to left gate V_L

- Tunneling rates:

Tunneling to right lead ~ 2 MHz

Tunneling to left lead ~ 100 MHz

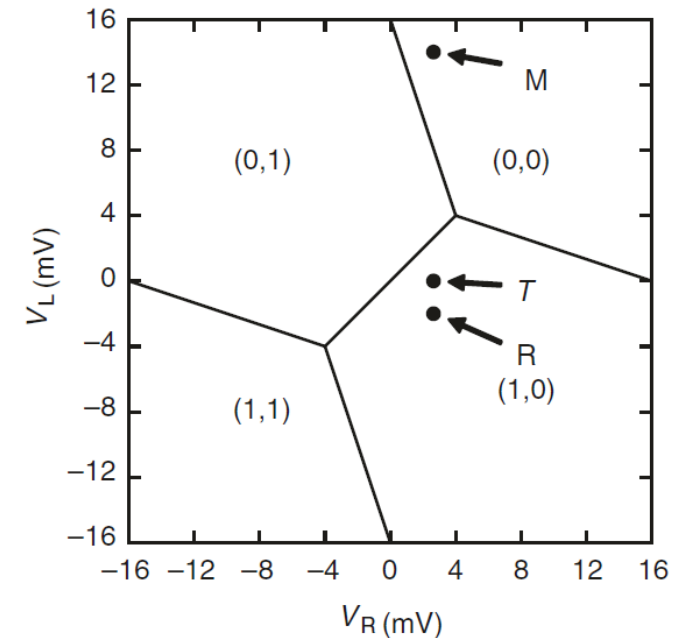
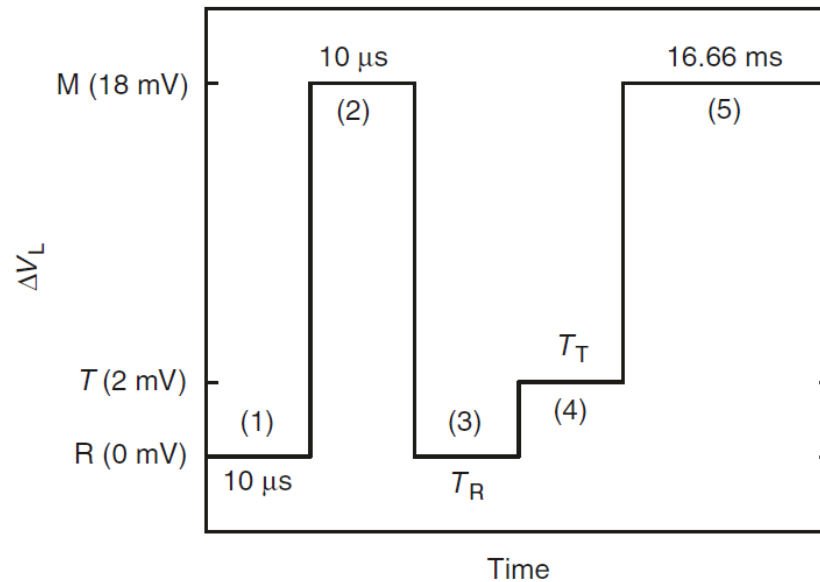
Resonant interdot tunneling ~ 50 MHz

Inelastic interdot tunneling ~ 0.5 MHz

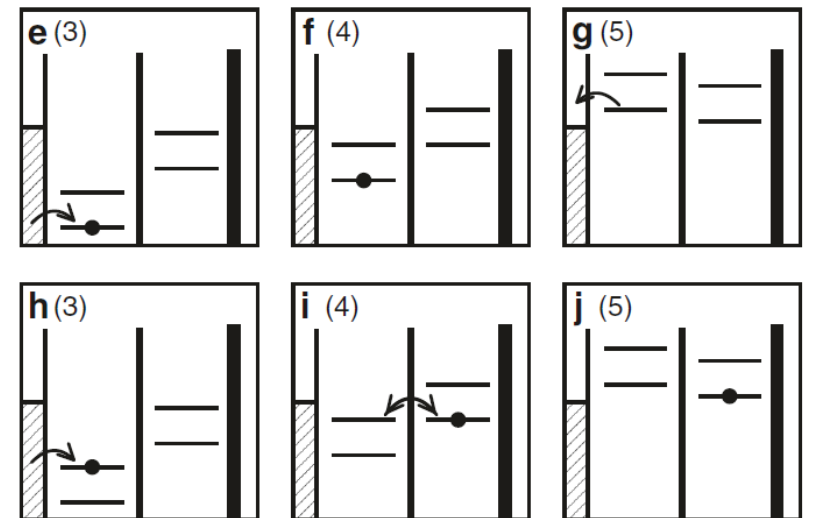
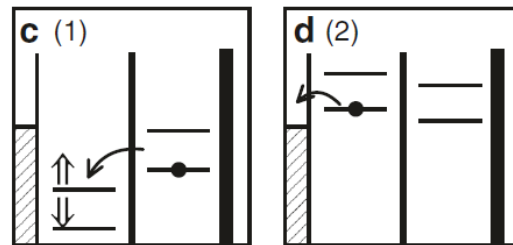
- Detected latched charge (0,1)

[(0,0)] corresponds to spin up

[down] in left dot



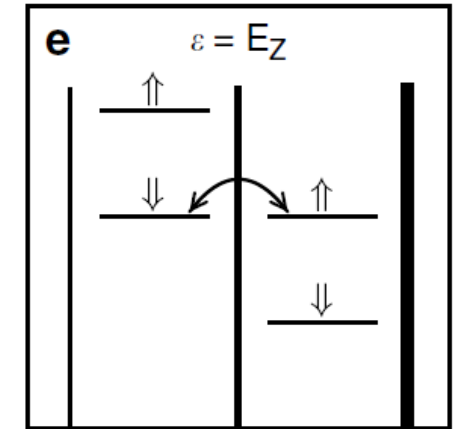
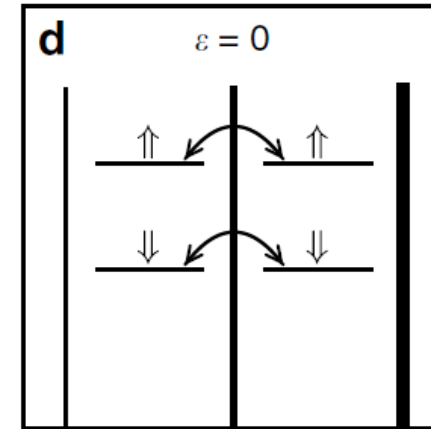
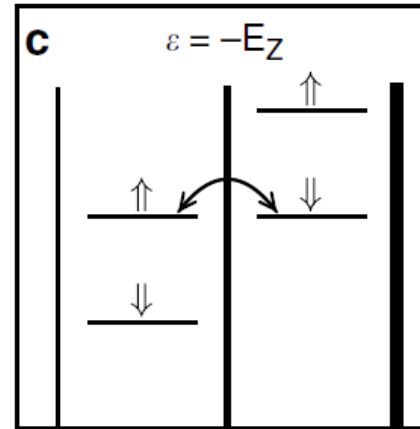
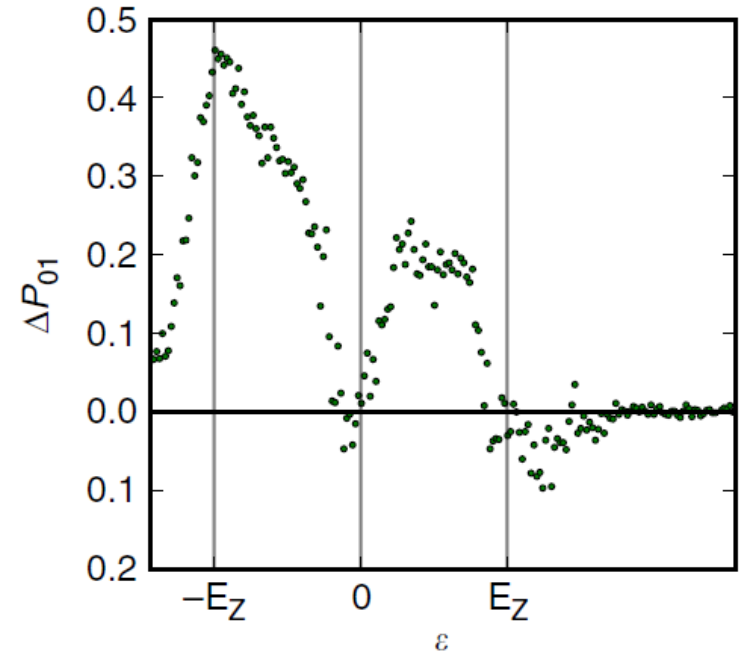
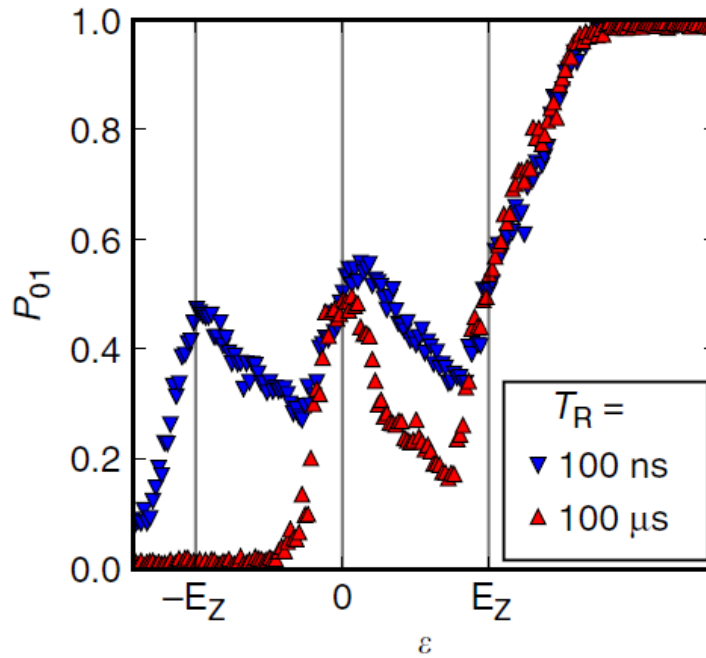
Here: $T_T = 100$ ns



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Protocol sensitivity

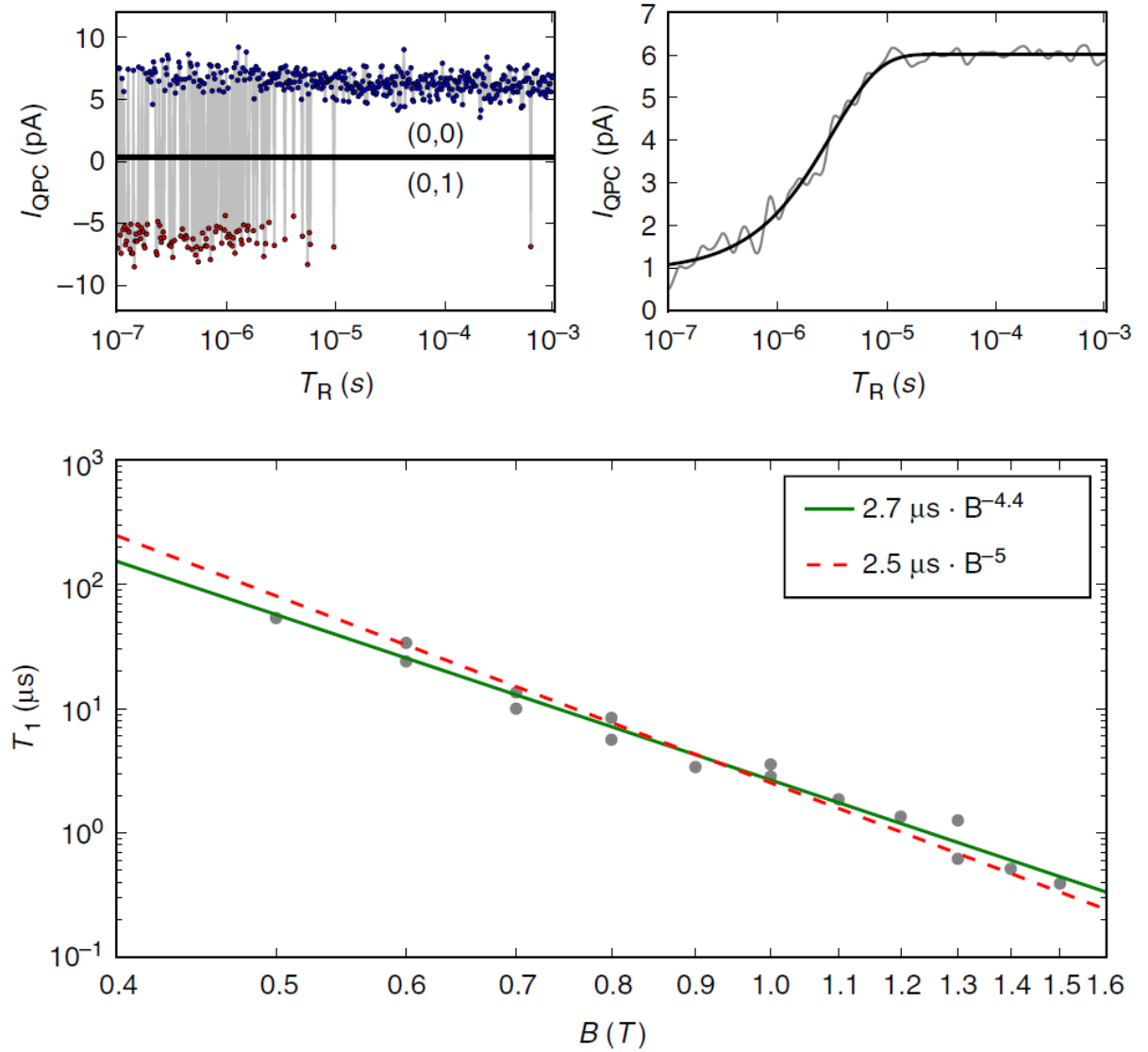
- Average probability P_{01} in 1000 measurements depending on detuning ε for two different values of T_R
- Change in ΔP_{01} indicates sensitivity to spin relaxation at different detuning
- $\varepsilon \gg E_Z$: Sensitivity is lost as initial alignment (1) becomes inverted ($P_{01} \sim 1$)
- Fidelity of protocol: $F_{\downarrow} = P((0,0)|L_{\downarrow}) = 0.99$
 $F_{\uparrow} = P((0,1)|L_{\uparrow}) = 0.52$ (distributed charge)



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Extraction of T_1

- Measure single-shot I_{QPC} values
- Gaussian averaging of 1000 measurements for each T_R
- Fit to $I_{\text{QPC}}(T_R) = I_0 + I_1 \left(1 - e^{-T_R/T_1}\right)$ in order to obtain T_1 for different B



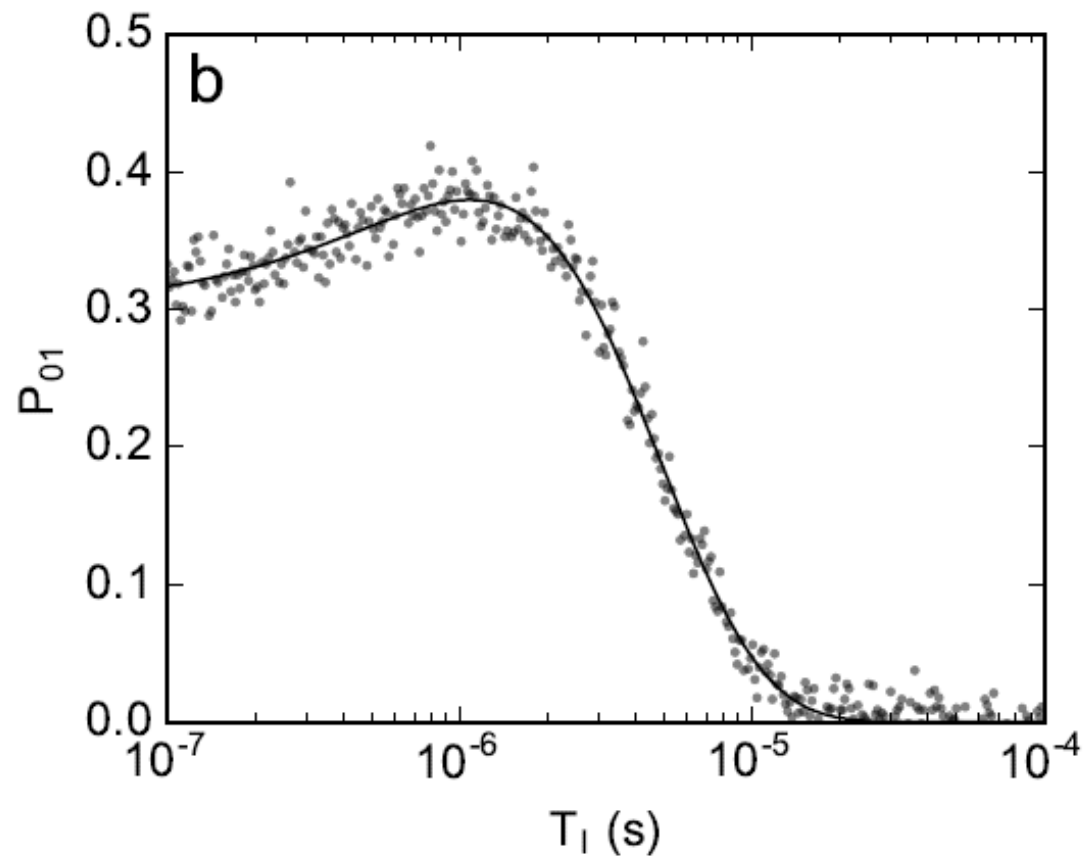
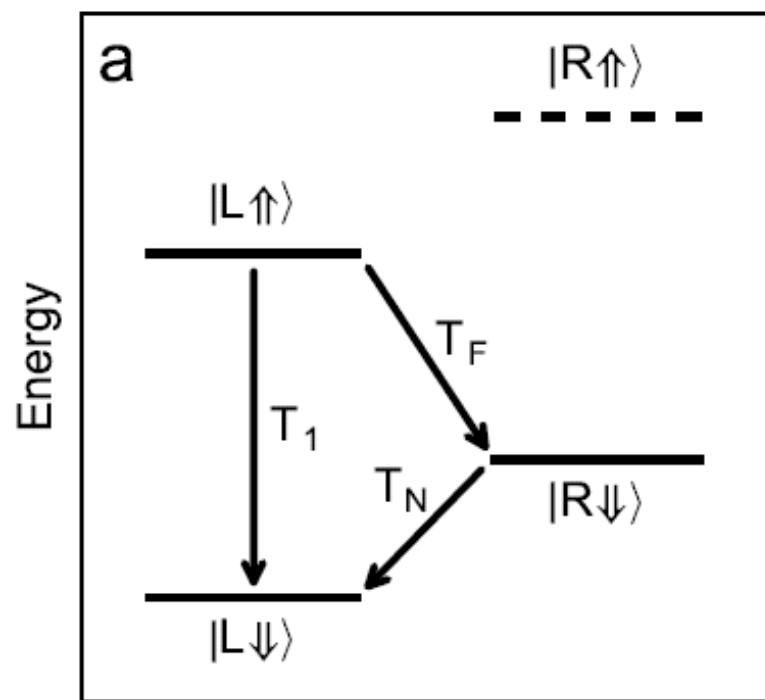
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Summary

- Measured T_1 ~400 ns at 1.5 T up to ~60 μ s at 0.5 T with latched charge sensing technique
- $T_1 \propto B^{-4.4}$ in this range, indicating dominance of Dresselhaus SOI
- For low magnetic field, scaling of holes $\propto B^{-5}$ is promising (compared to B^{-3} for electrons in GaAs, limited by hyperfine interactions)

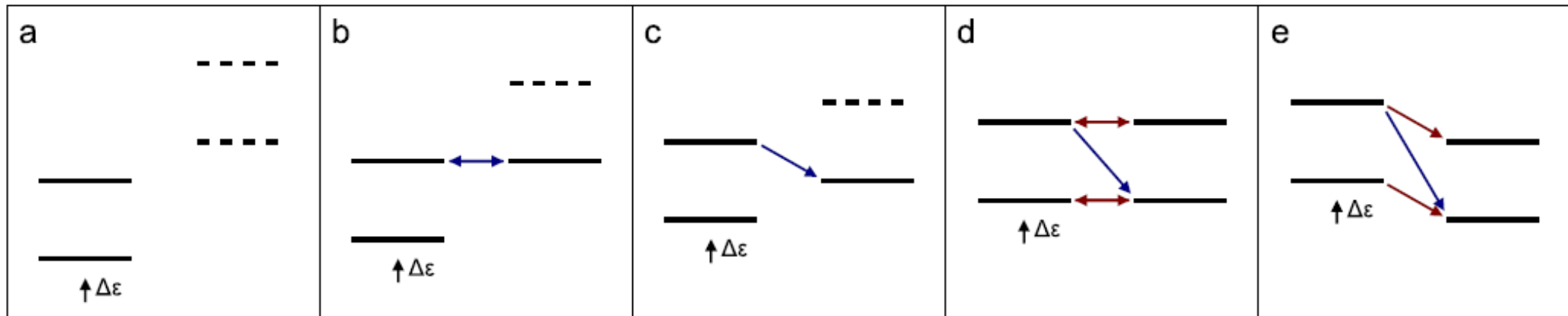
Initial state characterization

Hold for variable time T_1 (after stage four) at $\varepsilon = -E_z/2$ to characterize initial occupancy



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Measuring sensitivity



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